

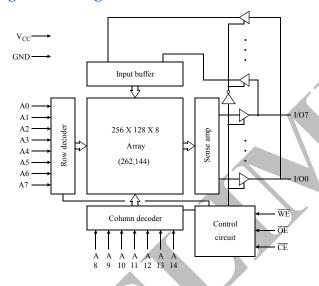
3.3V 32K X 8 CMOS SRAM (Common I/O)

Features

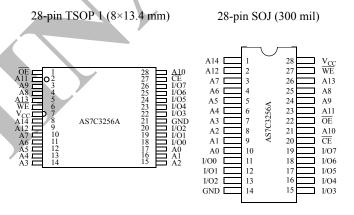
- Organization: 32,768 words × 8 bits
- · High speed
 - 8 ns address access time
- 5 ns output enable access time
- Very low power consumption: ACTIVE
- 216mW max @ 8 ns
- Very low power consumption: STANDBY
 - 7.2 mW max CMOS I/O

- Easy memory expansion with $\overline{\text{CE}}$ and $\overline{\text{OE}}$ inputs
- TTL-compatible, three-state I/O
- 28-pin JEDEC standard packages
- 300 mil SOJ
- $8 \times 13.4 \text{ mm TSOP } 1$
- ESD protection ≥ 2000 volts
- Latch-up current ≥ 200 mA

Logic block diagram



Pin arrangement



Selection guide

	-8	Unit
Maximum address access time	8	ns
Maximum output enable access time	5	ns
Maximum operating current	60	mA
Maximum CMOS standby current	2	mA



Functional description

The AS7C3256A is a 3.3V high-performance CMOS 262,144-bit Static Random-Access Memory (SRAM) device organized as 32,768 words × 8 bits. It is designed for memory applications requiring fast data access at low voltage, including PentiumTM, PowerPCTM, and portable computing. Alliance's advanced circuit design and process techniques permit 3.3V operation without sacrificing performance or operating margins.

The device enters *standby mode* when $\overline{\text{CE}}$ is high. CMOS standby mode consumes 7.2 mW. Normal operation offers 75% power reduction after initial access, resulting in significant power savings during CPU idle, suspend, and stretch mode.

Equal address access and cycle time (t_{AA}, t_{RC}, t_{WC}) of 8 ns with output enable access time (t_{OE}) of 5 ns are ideal for high-performance applications. The chip enable (\overline{CE}) input permits easy memory expansion with multiple-bank memory organizations.

A write cycle is accomplished by asserting chip enable (\overline{CE}) and write enable (\overline{WE}) LOW. Data on the input pins I/O0-I/O7 is written on the rising edge of \overline{WE} (write cycle 1) or \overline{CE} (write cycle 2). To avoid bus contention, external devices should drive I/O pins only after outputs have been disabled with output enable (\overline{OE}) or write enable (\overline{WE}) .

A read cycle is accomplished by asserting chip enable ($\overline{\text{CE}}$) and output enable ($\overline{\text{OE}}$) LOW, with write enable ($\overline{\text{WE}}$) high. The chip drives I/O pins with the data word referenced by the input address. When chip enable or output enable is high, or write enable is low, output drivers stay in high-impedance mode.

All chip inputs and outputs are TTL-compatible. Operation is from a single 3.3 ± 0.3 V supply. The AS7C3256A is packaged in high volume industry standard packages.

Absolute maximum ratings

Parameter	Symbol	Min	Max	Unit
Voltage on V _{CC} relative to GND	V _{t1}	-0.5	+5.0	V
Voltage on any pin relative to GND	V _{t2}	-0.5	$V_{CC} + 0.5$	V
Power dissipation	P_{D}	/-	1.0	W
Storage temperature (plastic)	T_{stg}	-65	+150	°C
Ambient temperature with V _{CC} applied	T _{bias}	-55	+125	°C
DC current into outputs (low)	I _{OUT}	_	20	mA

Stresses greater than those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions outside those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

Truth table

CE	WE	OE	Data	Mode
Н	X	X	High Z	Standby (I _{SB} , I _{SB1})
L	Н	Н	High Z	Output disable (I _{CC})
L	Н	L	D _{OUT}	Read (I _{CC})
L	L	X	D_{IN}	Write (I _{CC})

Key: X = Don't care, L = Low, H = High



Recommended operating conditions

Parameter	Symbol	Min	Typical	Max	Unit	
Supply voltage		V _{CC}	3.0	3.3	3.6	V
Input voltage		V _{IH} **	2.0	_	V _{CC} +0.5	V
Input voltage		${ m V_{IL}}^*$	-0.5	_	0.8	V
Ambient operating temperature	commercial	$T_{\mathbf{A}}$	0	_	70	°C

DC operating characteristics (over the operating range)¹

			-	8	
Parameter	Sym	Test conditions	Min	Max	Unit
Input leakage current	$ I_{LI} $	$V_{CC} = Max,$ $V_{in} = GND \text{ to } V_{CC}$		1)	μА
Output leakage current	$ I_{LO} $	$V_{CC} = Max,$ $V_{OUT} = GND \text{ to } V_{CC}$	\-\(\)	1	μΑ
Operating power supply current	I_{CC}	$V_{CC} = Max, \overline{CE} \le V_{IL}$ $f = f_{Max}, I_{OUT} = 0mA$		60	mA
Standby power supply	I_{SB}	$V_{CC} = Max, \overline{CE} \ge V_{IH}$ $f = f_{Max}$	-	30	mA
current	I_{SB1}	$\begin{aligned} &V_{CC} = Max, \overline{CE} \geq V_{CC} - 0.2V \\ &V_{IN} \leq 0.2V \text{ or} \\ &V_{IN} \geq V_{CC} - 0.2V, f = 0 \end{aligned}$	I	2.0	mA
Output voltage	V _{OL}	$I_{OL} = 8 \text{ mA}, V_{CC} = \text{Min}$	_	0.4	V
Output voltage	V _{OH}	$I_{OH} = -4 \text{ mA}, V_{CC} = \text{Min}$	2.4	_	V

Capacitance (f = 1MHz, T_a = room temperature, V_{CC} = NOMINAL)⁴

Parameter	Symbol	Signals	Test conditions	Max	Unit
Input capacitance	C _{IN}	$A, \overline{CE}, \overline{WE}, \overline{OE}$	$V_{in} = 0V$	5	pF
I/O capacitance	$C_{I/O}$	I/O	$V_{in} = V_{out} = 0V$	7	pF



 $[*]_{**}V_{IL}$ min = -1.0V for pulse width less than 5ns. V_{IH} max = V_{CC} + 2.0V for pulse width less than 5ns.



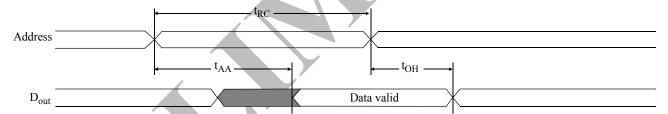
Read cycle (over the operating range)^{2,8}

		-8			
Parameter	Symbol	Min	Max	Unit	Notes
Read cycle time	t_{RC}	8	_	ns	7
Address access time	t_{AA}	_	8	ns	2
Chip enable (\overline{CE}) access time	t _{ACE}	_	8	ns	2
Output enable (OE) access time	t _{OE}	_	5	ns	
Output hold from address change	t _{OH}	3	-	ns	4
CE LOW to output in low Z	t_{CLZ}	3		ns	3,4
CE HIGH to output in high Z	t_{CHZ}	_	3	ns	3,4
OE LOW to output in low Z	t _{OLZ}	0	-	ns	3,4
OE HIGH to output in high Z	t _{OHZ}	_	3	ns	3,4
Power up time	t_{PU}	0	- /	ns	3,4
Power down time	t_{PD}		10	ns	3,4

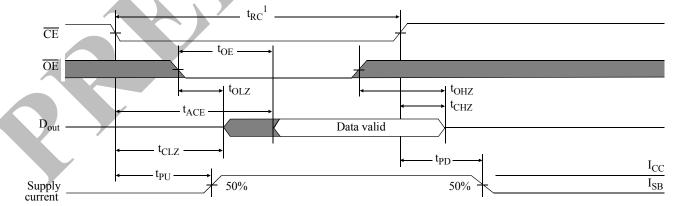
Key to switching waveforms

Rising input Falling input Undefined output/don't care

Read waveform 1 (address controlled)^{2,5,6,8}



Read waveform 2 (CE controlled)^{2,5,7,8}

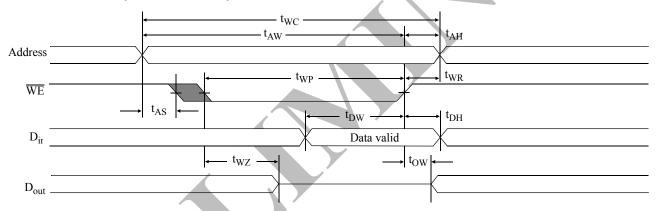




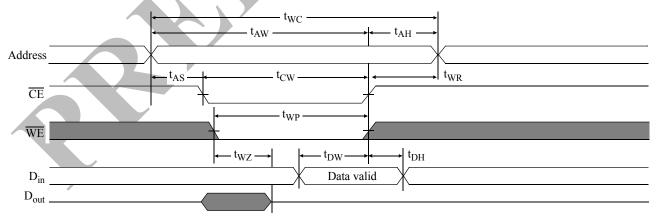
Write cycle (over the operating range)⁹

		-8			
Parameter	Symbol	Min	Max	Unit	Notes
Write cycle time	t_{WC}	8	-	ns	
Chip enable to write end	t_{CW}	8	_	ns	
Address setup to write end	$t_{ m AW}$	8	_	ns	,
Address setup time	t_{AS}	0	-	ns	
Write pulse width	t_{WP}	7	_	ns	
Write recovery time	t_{WR}	0	-	ns	
Address hold from end of write	$t_{ m AH}$	0	-	ns	
Data valid to write end	t_{DW}	5	_	ns	
Data hold time	$t_{ m DH}$	0	-	ns	3,4
Write enable to output in high Z	$t_{ m WZ}$	- ,	5	ns	3,4
Output active from write end	t_{OW}	3	-	ns	3,4

Write waveform 1 (WE controlled)9



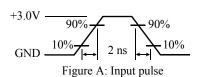
Write waveform 2 (CE controlled)9

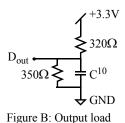


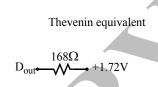


AC test conditions

- Output load: see Figure B
- Input pulse level: GND to 3.0V. See Figure A.
- Input rise and fall times: 2 ns. See Figure A.
- Input and output timing reference levels: 1.5V.







Notes

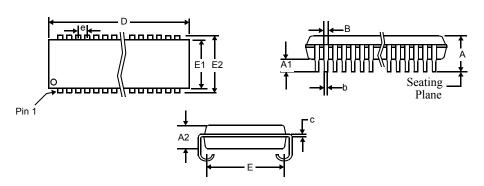
- 1 During V_{CC} power-up, a pull-up resistor to V_{CC} on \overline{CE} is required to meet I_{SB} specification.
- 2 For test conditions, see AC Test Conditions, Figures A, B.
- 3 These parameters are specified with CL = 5pF, as in Figures B. Transition is measured ±500mV from steady-state voltage.
- 4 This parameter is guaranteed, but not tested.
- 5 WE is High for read cycle.
- \overline{CE} and \overline{OE} are Low for read cycle.
- 7 Address valid prior to or coincident with \overline{CE} transition Low.
- 8 All read cycle timings are referenced from the last valid address to the first transitioning address.
- 9 All write cycle timings are referenced from the last valid address to the first transitioning address.
- 10 C=30pF, except on High Z and Low Z parameters, where C=5pF.





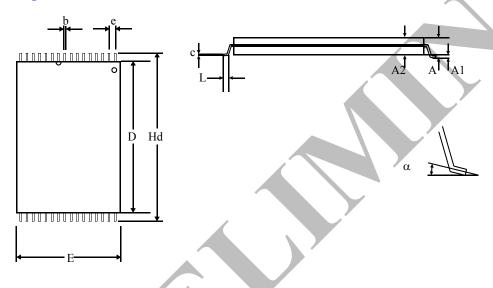
Package diagrams

28-pin SOJ



	28-pin SOJ				
	28-pii	1 SOJ			
	Min	Max			
	in in	ches			
A	0.128	0.148			
A1	0.026	ļ			
A2	0.095	0.105			
В	0.026	0.032			
b	0.016	0.020			
c	0.007	0.010			
D	0.720	0.730			
E	0.255	0.275			
E 1	0.295	0.305			
E2	0.330	0.340			
e	0.050	BSC			

28-pin TSOP1



	28-pin TSOP1			
	8×13.	4 mm		
	Min	Max		
A	1.00	1.20		
A1	0.05	0.15		
A2	0.91	1.05		
b	0.17	0.27		
c	0.10	0.20		
D	11.70	11.90		
e	0.55 n	ominal		
E	7.90	8.10		
Hd	13.20	13.60		
L	0.50	0.70		
α	0°	5°		

P. 8 of 9



Ordering information

Package	Temperature	8 ns
Plastic SOJ, 300 mil	Commercial	AS7C3256A-8JC
TSOP 8x13.4mm	Commercial	AS7C3256A-8TC

Note: Add suffix 'N'to the above part number for lead free parts. (Ex. AS7C3256A-8JCN)

Part numbering system

AS7C	3	256A	–XX	X	C	X
SRAM prefix	Voltage: 3 = 3.3V supply	Device number		I - SOI 200 mil	Temperature range: C = 0 °C to 70 °C	N= Lead Free Part







Alliance Semiconductor Corporation 2575, Augustine Drive, Santa Clara, CA 95054 Tel: 408 - 855 - 4900

Fax: 408 - 855 - 4999

www.alsc.com

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